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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/735,402	LOVETT ET AL.	
Examiner	Art Unit	
John Chavis	2193	

John Chavis

SEARCHED				
Class	Subclass	Date	Examiner	
717	151	1/18/2007	JC .	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
717	151	1/18/2007)C	
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